MOSFET - Power, Single

N-Channel

80 V, 20 mΩ, 30 A

NVTFS6H860NL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS6H860NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	80	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	30	Α
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		21	
Power Dissipation	State	T _C = 25°C	P_{D}	42	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		21	
Continuous Drain		T _A = 25°C	I _D	8.1	Α
Current R _{0JA} (Notes 1, 3, 4)	Steady	T _A = 100°C		5.7	
Power Dissipation	State	T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1, 3)	T _A = 100°C		1.6		
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	122	Α
Operating Junction and Range	Storage T	emperature	T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	35	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.5 A)			E _{AS}	121	mJ
Lead Temperature for S (1/8" from case for 10 s)		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{ heta JC}$	3.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

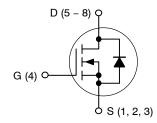


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
80 V	20 mΩ @ 10 V	30 A	
	26 mΩ @ 4.5 V	30 A	

N-Channel



WDFN8 (μ8FL) CASE 511AB

MARKING DIAGRAMS





WDFNW8 (Full-Cut μ8FL) CASE 515AN



XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						ı	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		80			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,				10	μΑ
		$V_{DS} = 80 \text{ V}$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _G	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 5)	•						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 30 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5 A		16.5	20	mΩ
		V _{GS} = 4.5 V	I _D = 5 A		20.5	26	mΩ
Forward Transconductance	9FS	V _{DS} = 8 V, I _D	= 15 A		45		S
CHARGES, CAPACITANCES & GATE	E RESISTANCE				•	•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 40 V			610		
Output Capacitance	C _{OSS}				83		pF
Reverse Transfer Capacitance	C _{RSS}				5		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 15 A			12		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 40 V; I _D = 15A			1		
Gate-to-Source Charge	Q _{GS}				2		nC
Gate-to-Drain Charge	Q_{GD}				2		
Plateau Voltage	V_{GP}				3		V
Total Gate Charge	Q _{G(TOT)}				6		nC
SWITCHING CHARACTERISTICS (N						ı	
Turn-On Delay Time	t _{d(ON)}				8		
Rise Time	t _r	V _{GS} = 4.5 V, V _E	oc = 64 V.		32		
Turn-Off Delay Time	t _{d(OFF)}	I _D = 15 A, R _G	$= 2.5 \Omega$		14		ns
Fall Time	t _f				5		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS				1	<u>I</u>	L
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.80	1.2	
		$I_S = 5 A$	T _J = 125°C		0.66		- V
Reverse Recovery Time	t _{RR}				29		
Charge Time	ta	$V_{CS} = 0.V dIS/dt$	= 100 A/us		18		ns
Discharge Time	t _b	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 15 \text{ A}$			11		1
Reverse Recovery Charge	Q _{RR}				21		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

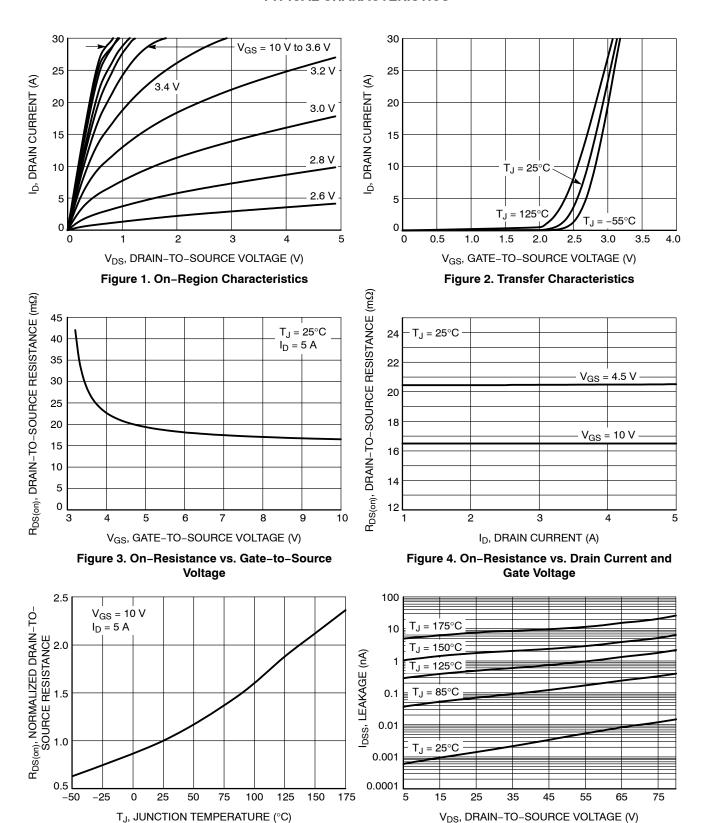


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

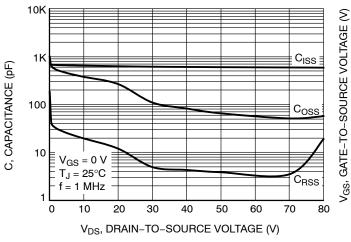


Figure 7. Capacitance Variation

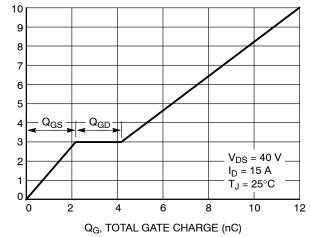


Figure 8. Gate-to-Source and

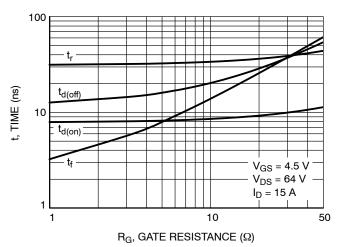


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

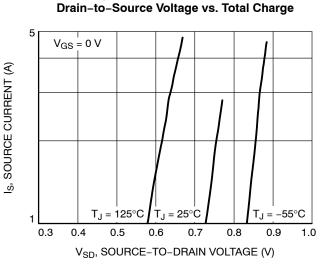


Figure 10. Diode Forward Voltage vs. Current

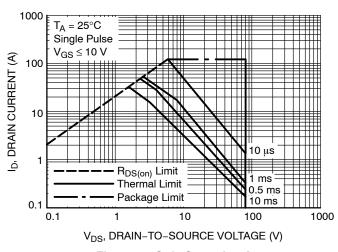


Figure 11. Safe Operating Area

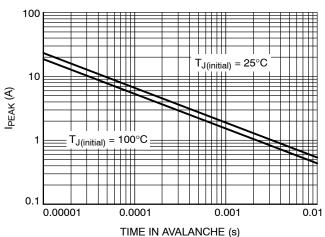


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

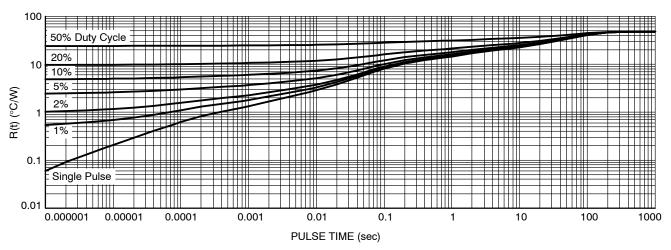


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS6H860NLTAG	860L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS6H860NLWFTAG	60LW	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

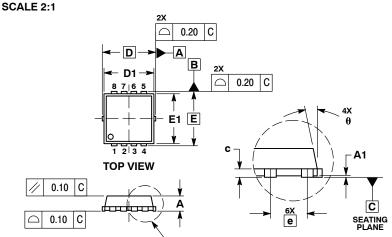
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DETAIL A

DATE 23 APR 2012

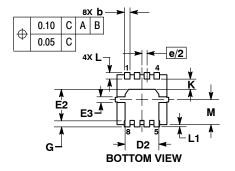


DETAIL A

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	(0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



GENERIC MARKING DIAGRAM*

SIDE VIEW

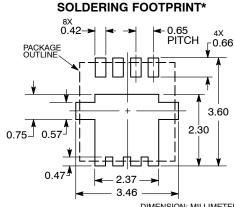


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

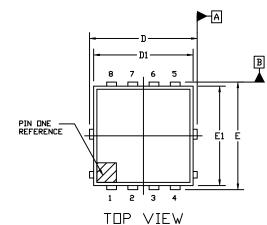
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN ISSUE O

DATE 25 AUG 2020



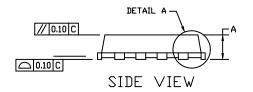


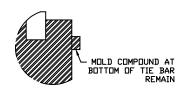


- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

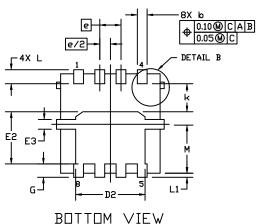
		PLATED AREA
A1	DETAIL A	C SEATING PLANE

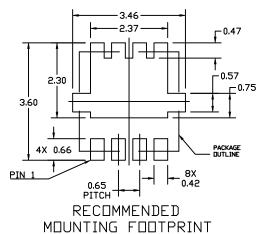
	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
Α	0.70	0.75	0.80	
A1	0.00		0.05	
Ø	0.23	0.30	0.40	
n	0.15	0.20	0.25	
D	3.05	3.30	3.55	
D1	2.95	3.05	3.15	
D2	1.98	2.11	2.24	
E	3.05	3.30	3.55	
E1	2.95	3.05	3.15	
E2	1.47	1.60	1.73	
E3	0.23	0.30	0.40	
a		0.65 BSC		
G	0.30	0.41	0.51	
K	0.65	0.80	0.95	
٦	0.30	0.43	0.59	
L1	0.06	0.13	0.20	
M	1.40	1.50	1.60	





DETAIL B





* For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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